

solution for examining surfaces with varying curvatures and geometries. They can be held in the hand or in a small probe holder, making them a versatile tool for initial testing and proof of concept verification before transitioning to a rigid probe with a fixed geometry.

The SHAPE-P-053-MR-f probe is a mid-resolution inspection probe, manufactured with no rubber backing, resulting in the ultimate probe flexibility. These probes have been field-proven as an excellent "all-rounder".

The SHAPE probe can be customized to meet specific requirements, making it the ultimate tool for surface Eddy Current Array examination.

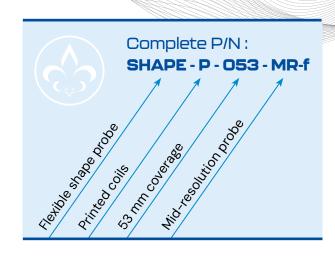
## SHAPE-P-053-MR-f

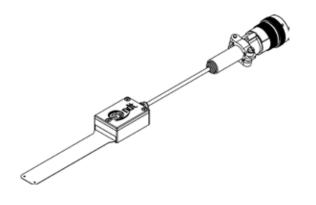
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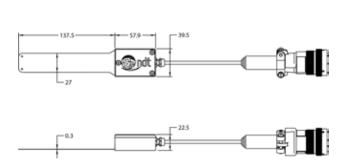
## SHAPE-P-053-MR-f

## Interchangeability

The flexible array is easily detached from the cable and multiplexer (MUX) assembly and replaced using a single tool. This means that the array can be quickly and easily replaced by other similar arrays with a different coverage, resolution or topology.









## **Through innovation,** we surpass standard expectations

